

Clause 163, 120F Comment Resolution

Phil Sun

Credo Semiconductor

Comments to be Discussed

Category	Comment ID	Notes
Test fixture	64, 227, [65, 161]	
Vf/vpeak/erl	[13, 5], [61, 83, 84]	
RITT Np	[279, <u>li_3ck_01_1020.pdf</u>], [280, 86]	For CL163, Annex 120F
RITT	[71, <u>ran_3ck_03_1020?</u> , 166, 194], 2, [70, 231], 168	
SNDR	226	
Example Test Fixture	228, [73, 6, 26, 162, 204, 229, 13	

Test Fixture ILD Comment # 64

CI 163 SC 163.9.2.1.1 P 177 L 48 # 64
 Ran, Adee Intel
 Comment Type T Comment Status D test fixture
 ILD definition in 93A.4 should be cross referenced.
 This definition requires some parameters. Specifically the transition time T_t , which should correspond to the observable transition time at TP0 (larger than the internal value).
 Suggested Remedy
 Append "Insertion loss deviation is calculated as specified in 93A.4, where T_t is 0.1 ns, and f_b and f_t values are taken from Table 163-11."
 Proposed Response Response Status W
 PROPOSED ACCEPT.

Spec being commented:

163.9.2.1.1 Test fixture insertion loss

The insertion loss of the test fixture shall be less than 5 dB at 26.56 GHz. The magnitude of the insertion loss deviation of the test fixture shall be less than or equal to 0.2 dB from 0.05 to 26.56 GHz.

References:

93A.4 Insertion loss deviation

The insertion loss deviation $ILD(f)$ is the difference between the measured insertion loss $IL(f)$ and the fitted insertion loss $IL_{fitted}(f)$ (see 93A.3) as shown in Equation (93A-55).

$$ILD(f) = IL(f) - IL_{fitted}(f) \quad (93A-55)$$

A figure of merit for a channel that is based on $ILD(f)$ is given by Equation (93A-56). In Equation (93A-56), f_n are the frequencies considered in the computation of the fitted insertion loss and $W(f_n)$ is the weight at each frequency as defined by Equation (93A-57).

$$FOM_{ILD} = \left[\frac{1}{N} \sum_n W(f_n) ILD^2(f_n) \right]^{1/2} \quad (93A-56)$$

$$W(f_n) = \text{sinc}^2(f_n/f_b) \left[\frac{1}{1 + (f_n/f_t)^4} \right] \left[\frac{1}{1 + (f_n/f_r)^8} \right] \quad (93A-57)$$

The variable f_b is the signaling rate. The 3 dB transmit filter bandwidth f_t is inversely proportional to the 20% to 80% rise and fall time T_r . The constant of proportionality is 0.2365 (e.g., $T_r f_t = 0.2365$; with f_t in Hertz and T_r in seconds). The variable f_r is the 3 dB reference receiver bandwidth.

The values assigned to f_b , T_r , and f_r are defined by the Physical Layer specification that invokes this method.

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47
48

Test Fixture Minimum Loss Comment # 227

CI 163 SC 163.9.2.1.1 P 177 L 47 # 227

Dawe, Piers Nvidia

Comment Type **T** Comment Status **D** test fixture

Try to exclude unexplored / unnecessary areas of inaccuracy or poor reproducibility in measurement.

SuggestedRemedy

Set a minimum insertion loss for this test fixture as well as a maximum. It could be as low as 1.2 dB which we had before for TP0a, or it could be higher.

Proposed Response Response Status **W**

PROPOSED ACCEPT IN PRINCIPLE.

Add minimum IL 1.2dB.
For task force discussion.

Spec being commented:

163.9.2.1.1 Test fixture insertion loss

45
46
47
48

The insertion loss of the test fixture shall be less than 5 dB at 26.56 GHz. The magnitude of the insertion loss deviation of the test fixture shall be less than or equal to 0.2 dB from 0.05 to 26.56 GHz.

Test Fixture ERL Comment [# 65, #161]

Spec being commented:

Cl 163 SC 163.9.2.1.2 P 178 L 21 # 65
Ran, Adee Intel
Comment Type T Comment Status D test fixture

Per resolution of comment 154 against D1.2 there should be a requirement on test fixture ERL:

"The ERL at TP0v shall be greater than or equal to TBD".

This part has not been implemented.

With N=20 the ERL of the test fixture is expected to be very good. The TBD may be changed to 15 dB (same as in clause 137) if there is consensus.

SuggestedRemedy

Add the following sentence after the table"

"The ERL at TP0v shall be greater than or equal to TBD dB".

Consider changing TBD to 15 dB.

Proposed Response Response Status W

PROPOSED ACCEPT.

[Editor's note: Addresses incomplete specification.]

163.9.2.1.2 Test fixture effective return loss

ERL of the test fixture at TP0v is computed using the procedure in 93A.5 with the values in Table 163–6. Parameters that do not appear in Table 163–6 take values from Table 163–11.

Table 163–6—Test fixture ERL parameter values

Parameter	Symbol	Value	Units
Transition time associated with a pulse	T_r	0.01	ns
Incremental available signal loss factor	β_x	0	GHz
Permitted reflection from a transmission line external to the device under test	ρ_x	0.618	—
Length of the reflection signal	N	20	UI
Equalizer length associated with reflection signal	N_{bx}	0	UI
Twice the propagation delay associated with the test fixture	T_{fx}	0	ns
Tukey window flag	nv	1	—

Cl 163 SC 163.9.2.1.2 P 178 L 5 # 161
Dudek, Mike Marvell.
Comment Type T Comment Status D test fixture

There is no specification for the ERL of the test fixture

SuggestedRemedy

Insert a Paragraph "The ERL of the test fixture shall be greater than TBD dB"

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

[Editor's note: Addresses incomplete specification.]

Resolve using the response to comment #65.

TP0v V_peak Comment [# 13, #5]

CI 120F SC 120F.3.1 P 208 L 20 # 13
 Mellitz, Richard Samtec
 Comment Type TR Comment Status D vpeak

We need to specify V_peak/V_f not V_peak I.e. pulse peak loss

SuggestedRemedy

Change
 Difference between measured and reference linear fit pulse peak
 To
 Difference between measured and reference linear fit pulse peak loss (min) d(V_peak/V_f)

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

It is assumed that the comment is requesting that the specification be for the ration of V_peak/V_f, rather than just V_peak.
 If that is the case, implement the following with editorial license...
 To make the parameter easier to read and use, define the ratio R_peak equal to V_peak/V_f.
 Define the difference between the reference and measured ratio as dR_peak.
 For task force review.
 [Editor's note: CC: 163, 120F]

CI 163 SC 163.9.2 P 176 L 50 # 5
 Mellitz, Richard Samtec
 Comment Type TR Comment Status D terminology

We need to specify V_peak/V_f not V_peak. I.e. pulse peak loss

SuggestedRemedy

Change
 Difference between measured and reference linear fit pulse peak
 To
 Difference between measured and reference linear fit pulse peak loss (min) d(V_peak/V_f)

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Resolve using response to comment #13
 [Editor's note: CC: 163, 120F]

Spec being commented:

Difference between measured and reference linear fit pulse peak (min), dV_{peak}	163A.3.2.1	TBD	V	50
				51
				52

TP0v Thresholds Comment [# 61, #83, #84]

CI 163 SC 163.9.2 P 176 L 44 # 61
 Ran, Adee Intel
 Comment Type T Comment Status D vf/vpeak/erl

Table 163-5 has multiple TBDs.

Reference ERL, v_f and v_{peak} are calculated with an idealized package model. Real products deviate from this model, so the limit values may need adjustment.

v_f and v_{peak} may be degraded by a device or package, but that can be mitigated using higher than minimum launch voltage and some equalization. So for dv_f and dv_{peak} , a minimum of 0 V may be acceptable.

There is no straightforward method to improve ERL. So to allow a wide range of implementations, the minimum dERL should be less than 0 dB. A minimum of -3 dB may be acceptable.

Suggested Remedy

Change value for dv_f in Table 163-5 from TBD to 0.

Change value for dv_{peak} in Table 163-5 from TBD to 0.

Change value for dERL in Table 163-5 from TBD to -3.

Proposed Response Response Status **W**

PROPOSED ACCEPT IN PRINCIPLE.

[Editor's note: Addresses incomplete specification.]

Implement suggested remedy

For task force discussion

[Editor's note: CC: 163, 120F]

References:

Difference between measured and reference effective return loss (min), d_{ERL}	163A.3.2.2	TBD	dB
Common-mode to common-mode return loss (min)	162.9.3.5	2	dB
Difference between measured and reference steady-state voltage (min), dv_f	163A.3.2.1	TBD	V
Difference between measured and reference linear fit pulse peak (min), dv_{peak}	163A.3.2.1	TBD	V

Notes: comment #5 proposes to change V_{peak} to V_{peak}/V_f

Apply to comment #83, #84

TP0v Thresholds Comment [# 61, #83, #84] Contd.

CI 120F SC 120F.3.1 P 208 L 18 # 83

Brown, Matt Huawei

Comment Type T Comment Status D vf

A value for dv_f is required. If an appropriate reference transmitter is defined, then a value of 0 should be correct.

SuggestedRemedy
Replace TBD with 0.

Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.

[Editor's note: Addresses incomplete specification.]
Implement the suggested remedy.
For task force review.

CI 120F SC 120F.3.1 P 208 L 21 # 84

Brown, Matt Huawei

Comment Type T Comment Status D vpeak

A value for dv_peak is required. If an appropriate reference transmitter is defined, then a value of 0 should be correct.

SuggestedRemedy
Replace TBD with 0.

Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.

[Editor's note: Addresses incomplete specification.]
Implement the suggested remedy.
For task force review.

Spec being commented:

Difference between measured and reference steady-state voltage, dv_f (min)	163A.3.2.1	TBD	V	18
				19
Difference between measured and reference linear fit pulse peak, dv_{peak} (min)	163A.3.2.1	TBD	V	20
				21

RITT Np for CL163 Comment # 279

Notes: this is Np for RITT

Cl 163 SC 163.9.3.3 P 182 L 3 # 279
Li, Mike Intel
Comment Type TR Comment Status D RITT
Np TBD
SuggestedRemedy
Np = 29, see li_3ck_01_0920
Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.
[Editor's note: Addresses incomplete specification.]
The referenced presentation is located here:
https://www.ieee802.org/3/ck/public/20_10/li_3ck_01_1020.pdf
Implement the suggested remedy.
For task force review.

Spec being commented:

- e) For the calculation of test channel COM, the following parameters are based on values measured from the test transmitter. The parameter SNR_{TX} is set to the measured value of SNDR with $Np = \text{TBD}$, the parameter R_{LM} is set to the measured value of R_{LM} , and the parameters A_{DD} and σ_{RJ} are calculated from the measured values of J_{3u} and J_{RMS} using Equation (163-2) and Equation (163-3) respectively, where $Q3$ is 3.2905.

RITT Np for 120F Comment [# 280, #86]

CI 120F SC 120F.3.2.3 P 213 L 1 # 280
Li, Mike Intel
Comment Type TR Comment Status D RITT
Np TBD
SuggestedRemedy
Np = 11, see li_3ck_01_0920
Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.
[Editor's note: Addresses incomplete specification.]
The referenced presentation is here:
https://www.ieee802.org/3/ck/public/20_10/li_3ck_01_1020.pdf
Implement the suggested remedy.
For task force review.

CI 120F SC 120F.3.2.3 P 213 L 1 # 86
Brown, Matt Huawei
Comment Type T Comment Status D RITT
For the SNDR measurement in item e) of receiver interference tolerance test considerations the value for N_p is not set.
SuggestedRemedy
Replace TBD with an appropriate value.
Proposed Response Response Status W
PROPOSED REJECT.
[Editor's note: Addresses incomplete specification.]
The suggested remedy does not give an actionable proposal.
Resolve using the response to comment #280.

Notes: this is Np for RITT

Spec being commented:

- e) For the calculation of test channel COM, the following parameters are based on values measured from the test transmitter. The parameter SNR_{TX} is set to the measured value of SNDR with $N_p = \text{TBD}$, the parameter R_{LM} is set to the measured value of R_{LM} , and the parameters A_{DD} and σ_{RJ} are calculated from the measured values of J_{4u} and J_{RMS} using Equation (120D-10), and Equation (120D-11), respectively.

RITT Channel ERL Comment [#71, #166, #194]

Cl 163 SC 163.9.3.3 P 181 L 42 # 71

Ran, Adee Intel
Comment Type T Comment Status D RITT

In item b, Equation 163-2 is a calculation of A_DD, not related to return loss.

The transmitter's test fixture only has an ERL spec, and that is defined from TP0v towards the DUT. It is not an appropriate ERL for TP5 replica (e.g. has only N=20 UI).

The breakout from the package is typically controlled by the PMD's vendor and is practically part of the DUT. Therefore we should not add ERL specifications for the TP5 replica - they may be irrelevant and even incorrect for a specific implementation.

This is similar to the case of a transmitter's test fixture where ERL is specified toward the DUT, but not from the DUT toward TP0v.

Instead, the test channel's ERL should be specified to meet the ERL specifications in 163.10.3.

Also applies in 120F.3.2.3 item b which has "The return loss of the test setup in Figure 93C-4 measured at TP5 replica towards TPt meets the return loss specifications in 163.9.2.1" - but there are no return loss specifications in 163.9.2.1 anymore.

Suggested Remedy

Replace item b with the following:

The return loss of the test channel measured at TP5a towards TPt meets the requirements in 163.10.3.

Apply similar change in 120F.3.2.3 with the reference to requirements in 120F.4.3 instead.

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Replace item b with "The return loss of the test channel measured at TP5a towards TPt meets the requirements in 163.10.3."

CC: 163, 120F

References:

163.10.3 Channel ERL

ERL of the channel at TP0 and at TP5 are computed using the procedure in 93A.5 with the values in Table 163-12. Parameters that do not appear in Table 163-12 take values from Table 163-11.

Channel ERL at TP0 and at TP5 shall be greater than or equal to **TBD** dB.

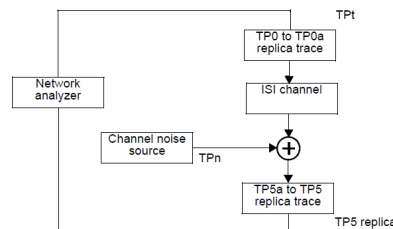


Figure 93C-4—Interference tolerance channel s-parameter test setup

Spec being commented:

- b) The return loss of the test setup in Figure 93C-4 measured at TP5 replica towards TPt meets the requirements of Equation (163-2).

RITT Channel ERL Comment [#71, #166, #194] Contd.

CI 163 SC 163.9.3.3 P 181 L 42 # 166
Dudek, Mike Marvell.
Comment Type **TR** Comment Status **D** RITT
Equation 163-2 is nothing to do with return loss. Also it would be better to use ERL as the parameter.
SuggestedRemedy
Change to "The ERL of the test setup in Figure 93C-4 measured at TP5 replica towards TPt meets the requirements for ERL in 163.9.2.1.2 with the exception that the length of the reflection signal N is 3500 UI"
Proposed Response Response Status **W**
PROPOSED ACCEPT IN PRINCIPLE.
Resolve using the response to comment #71

CI 163 SC 163.9.3.3 P 181 L 42 # 194
Wu, Mau-Lin MediaTek
Comment Type **T** Comment Status **D** RITT
The reference equation, Equation (163-2), is not correct. It shall be the original equation (equation 163-2) in D1p2 and be removed from D1p3.
SuggestedRemedy
Copy Equation 163-2 in D1p2 & related description to D1p3. Put them in the appropriate location & correct the referred Equation ID.
Proposed Response Response Status **W**
PROPOSED ACCEPT IN PRINCIPLE.
Resolve using the response to comment #71

Resolve using response to comment #71

RITT RSS_DFE4 Comment #2

CI 120F SC 120F.3.2.3 P 213 L 31 #

Mellitz, Richard

Samtec

Comment Type **TR** Comment Status **D** RITT

DFE4_RSS > 0.05 may be difficult to achieve with test equipment. The published C2C have a DFE4_RSS range between 0.03 V and 0.065 with a mean of 0.047 .

SuggestedRemedy

Since these represent design expectation set DFE4_RSS to 0.03 which would be achievable in test setups.

Proposed Response Response Status **W**

PROPOSED ACCEPT IN PRINCIPLE.

Implement the suggested remedy.
For task force discussion.

Spec being commented:

Table 120F-5—Receiver interference tolerance parameters

Parameter	Test 1 (low loss)			Test 2 (high loss)			Units
	Min	Max	Target	Min	Max	Target	
FEC Symbol error ratio ^a	—	10 ⁻⁴	—	—	10 ⁻⁴	—	—
Insertion loss at 26.5625 GHz ^b	9.5	10.5	—	19.5	20.5	—	dB
RSS_DFE4 ^c	0.05	—	—	0.05	—	—	—
COM including effects of broadband noise ^d	—	—	3	—	—	3	dB

RITT JTOL TX Setup Comment [#70, #231]

Cl 163 SC 163.9.3.3 P 181 L 34 # 70
Ran, Adee Intel
Comment Type T Comment Status D RITT

The exception that "transmitter equalization is configured by management..." is taken from the AUI-C2C (Annex 120D) which does not have a training protocol.

This clause is for the KR PMD that does have a training protocol defined, so this exception is out of place. The procedure in Annex 93C should be used as is.

SuggestedRemedy
Delete the sentence "with the exception that transmitter equalization is configured by management (see 120D.3.2.3) to the settings that provide the lowest FEC symbol error ratio".

Proposed Response Response Status W
PROPOSED ACCEPT.

Cl 163 SC 163.9.3.3 P 181 L 35 # 231
Dawe, Piers Nvidia
Comment Type T Comment Status D RITT

This isn't right: "transmitter equalization is configured by management (see 120D.3.2.3) to the settings that provide the lowest FEC symbol error ratio". It's the receiver's responsibility to choose an adequate transmitter equalization setting. Further, the transmitter could be a test instrument that doesn't do 802.3 management. What has 120D.3.2.3 got to do with it? Was this text copied from a C2C clause?

SuggestedRemedy
Correct the text. The transmitter equalization is what the receiver asks for after it's had a chance to train, or a default if it doesn't ask for anything in particular.
Same for 163.9.3.4 Receiver jitter tolerance.

Proposed Response Response Status W
PROPOSED ACCEPT IN PRINCIPLE.

Resolve the issue with 163.9.3.3 using the response to comment #70.
For 163.9.3.4, insert an exception as follows:
"a) The transmitter coefficients are set according to the procedure in 93C.2."
For task force review.

Spec being commented:

163.9.3.3 Receiver interference tolerance

Receiver interference tolerance is defined by the procedure in [Annex 93C](#) with the exception that transmitter equalization is configured by management (see [120D.3.2.3](#)) to the settings that provide the lowest FEC symbol error ratio. The receiver on each lane shall meet the FEC symbol error ratio requirement with

163.9.3.4 Receiver jitter tolerance

Receiver jitter tolerance is verified for each pair of jitter frequency and peak-to-peak amplitude values listed in Table 162–15. The test setup shown in [Figure 93–12](#), or its equivalent, is used. The test channel meets the insertion loss requirement for Test 2 in Table 163–10. The synthesizer frequency is set to the specified jitter frequency and the synthesizer output amplitude is adjusted until the specified peak-to-peak jitter amplitude for that frequency is measured at TP0v. The test procedure is the same as the one described in [120D.3.2.1](#), with the following exceptions:

References:

93C.2 Test method

The interference tolerance test is performed using the following method:

- 1) Set the channel noise source to zero.
- 2) Using the test setup in [Figure 93C–2](#), initiate the training sequence, allow the training sequence to complete, and retain the resulting transmitter tap coefficients.

RITT Tr Parameter Comment #168

CI 163 SC 163.9.3.3 P 181 L 50 # 168

Dudek, Mike Marvell.

Comment Type TR Comment Status D RITT

The relationship between T_r of the transmitter and the T_{rm} measurement will be a function of the loss between TP0 and TP0v and the Nyquist frequency. The equation used was only valid for the loss of the test fixture of 1.4dB with a Nyquist frequency of approx 12.5GHz.

Suggested Remedy

Replace the equation with TBD.

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Add an editor's note stating that this equation should be revisited.
For task force review.

References:

The voltage transfer function for each signal path $H_{21}^{(k)}(f)$ (see 93A.1.3) is multiplied by a set of filter transfer functions to yield $H^{(k)}(f)$ as shown in Equation (93A-19).

$$H^{(k)}(f) = H_{ffo}(f)H_r(f)H_{21}^{(k)}(f)H_s(f)H_{cif}(f) \quad (93A-19)$$

If the test transmitter presents a high-quality termination, e.g., it is a piece of test equipment, the transmitter device package model $S^{(tp)}$ is omitted from the calculation of $S_p^{(k)}$ and the filtered voltage transfer function $H^{(k)}(f)$ in 93A.1.4 includes the filter $H_r(f)$ defined by Equation (93A-46) where T_r is the 20% to 80% transition time (see 86A.5.3.3) of the signal as measured at TP0a.

$$H_r(f) = \exp(-2(\pi f T_r / 1.6832)^2) \quad (93A-46)$$

Spec being commented:

- d) In the calculation of COM, if the transmitter is a device with known S-parameters and transition time, these parameters should be used instead of the transmitter package model in 93A.1.2. If a calibrated instrument-grade transmitter is used, the transmitter device package model $S^{(tp)}$ is omitted from Equation (93A-3) in the calculation of COM. The filtered voltage transfer function $H^{(k)}(f)$ calculated in Equation (93A-19) uses the filter $H_r(f)$ defined by Equation (93A-46), where T_r is calculated as $T_r = 1.09 \times T_{rm} - 4.22$ ps and T_{rm} is the measured 20% to 80% transition time of the signal at TP0v. T_{rm} is measured using the method in 120E.3.1.5. T_{rm} is measured with the transmitter equalizer turned off.

SNDR Comment #226

CI 163 SC 163.9.2 P 177 L 12 # 226

Dawe, Piers Nvidia
 Comment Type E Comment Status D SNDR

It's surprising that the only definition of SNDR is table footnote c. The reader could miss the deviation from 120D.3.1.6.

Suggested Remedy

At least put 162.9.3.1.1 in the Reference column with 120D.3.1.6

Proposed Response Response Status W

PROPOSED REJECT.

Deviation from 120D.3.1.6 is described in the footnote c.

Spec being commented:

Table 163-5—Summary of transmitter specifications at TP0v (continued)

Parameter	Reference	Value	Units
Transmitter waveform ^b			
abs step size for $c(-3)$, $c(-2)$, $c(-1)$, $c(0)$, and $c(1)$ (min)	162.9.3.1.4	0.005	—
abs step size for $c(-3)$, $c(-2)$, $c(-1)$, $c(0)$, and $c(1)$ (max)	162.9.3.1.4	0.025	—
value at minimum state for $c(-3)$ (max)	162.9.3.1.5	-0.06	—
value at maximum state for $c(-2)$ (min)	162.9.3.1.5	0.12	—
value at minimum state for $c(-1)$ (max)	162.9.3.1.5	-0.34	—
value at minimum state for $c(0)$ (max)	162.9.3.1.5	0.54	—
value at minimum state for $c(1)$ (max)	162.9.3.1.5	-0.2	—
Signal-to-noise-and-distortion ratio SNDR (min) ^c	120D.3.1.6	32.5	dB
Jitter (max) ^d			
J_{RMS}	162.9.3.3	0.023	UI
J_{3u}	162.9.3.3	0.106	UI
Even-odd jitter, pk-pk ^e	162.9.3.3	0.019	UI

^aMeasurement uses the method described in 93.8.1.3 with the exception that the PRBS13Q test pattern is used.

^bImplementations are recommended to use the same step size for all coefficients

^cMeasurement uses the method described in 120D.3.1.6 with the exception that the linear fit procedure in 162.9.3.1.1 is used.

Note: 162.9.3.1.1 describes linear fitting procedure.

Test Fixture RL Frequency Range Comment #228

CI 163 SC 163.9.2.1.3 P 178 L 26 # 228

Dawe, Piers

Nvidia

Comment Type T Comment Status D example TF

It doesn't make sense to have an RL spec for the test fixture only to 26.56 GHz, while the spec for the item under test extends to 40 GHz (see 162.9.3.5, referenced from Table 163-5: is that the right cross-reference?)

Suggested Remedy

Provide a CM RL spec for the test fixture up to the same frequency as the product spec.

Proposed Response Response Status W

PROPOSED ACCEPT IN PRINCIPLE.

Change referece in Table 163-5 from 162.9.3.5 to 163.9.2.1.3.

Change the text in 163.9.2.1.3 to "The common-mode to common-mode return loss shall be greater than or equal to 2 dB at all frequencies between 0.2 GHz and 40 GHz."

References:

163.9.2.1.3 Test fixture common-mode return loss

The common-mode return loss of the test fixture shall be greater than or equal to 10 dB from 0.05 GHz to 26.56 GHz.

Spec being commented:

Common-mode to common-mode return loss (min)	162.9.3.5	2	dB
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